

August 1998

54ACTQ827

Quiet Series 10-Bit Buffer/Line Driver with TRI-STATE® Outputs

General Description

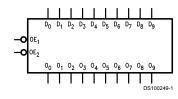
The 'ACTQ827 10-bit bus buffer provides high performance bus interface buffering for wide data/address paths or buses carrying parity. The 10-bit buffers have NOR output enables for maximum control flexibility. The 'ACTQ827 utilizes NSC Quiet Series technology to guarantee quiet output switching and improved dynamic threshold performance. FACT Quiet Series™ feature GTO™ output control and undershoot corrector in addition to a split ground bus for superior performance.

- Inputs and outputs on opposite sides of package allow easy interface with microprocessors
- Improved latch-up immunity
- Outputs source/sink 24 mA
- Functionally and pin-compatible to AMD's AM29827
- 'ACTQ827 has TTL-compatible inputs
- 4 kV minimum ESD immunity
- Standard Microcircuit Drawing (SMD) 5962-92199

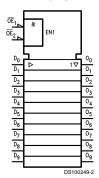
Features

 Guaranteed simultaneous switching noise level and dynamic threshold performance

Logic Symbols



IEEE/IEC



Pin Names Description	
\overline{OE}_1 , \overline{OE}_2	Output Enable
D ₀ -D ₉	Data Inputs
O ₀ -O ₉	Data Outputs

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TRI-STATE® is a registered trademark of National Semiconductor Corporation.

FACT® is a registered trademark of Fairchild Semiconductor Corporation.

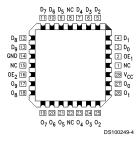
FACT Quiet Series™ is a trademark of Fairchild Semiconductor Corporation.

Connection Diagrams

Pin Assignment for DIP and Flatpak



Pin Assignment for LCC



Functional Description

The 'ACTQ827 line driver is designed to be employed as memory address driver, clock driver and bus-oriented transmitter/receiver. The devices have TRI-STATE outputs controlled by the Output Enable (\overline{OE}) pins. When the \overline{OE} is LOW, the device is transparent. When \overline{OE} is HIGH, the device vice is in TRI-STATE mode.

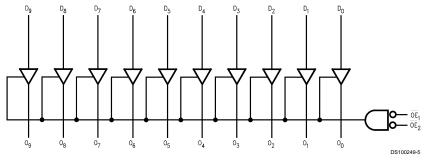
Function Table

Inputs		Outputs	Function		
OE D _n		On			
L	Н	Н	Transparent		
L	L	L	Transparent		
Н	Х	Z	High Z		

H = HIGH Voltage Level

L = LOW Voltage Level
Z = HIGH Impedance
X = Immaterial

Logic Diagram



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/ Distributors for availability and specifications.

Supply Voltage (V_{CC}) -0.5V to +7.0V DC Input Diode Current (I_{IK}) $V_{I} = -0.5V$ -20 mA

 $\label{eq:VI} \begin{array}{lll} \rm V_I = V_{CC} + 0.5V & +20~mA \\ \\ \rm DC~Input~Voltage~(V_I) & -0.5V~to~V_{CC} + 0.5V \end{array}$

DC Output Diode Current (I_{OK})

DC Output Source

or Sink Current (I_O)

DC V_{CC} or Ground Current per Output Pin (I_{CC} or I_{GND})

Storage Temperature (T_{STG})

DC Latch-Up Source or Sink Current

or Sink Current

Junction Temperature (T_J)

175°C

±300 mA

-55°C to +125°C

Recommended Operating Conditions

Supply Voltage (V_{CC})

 $\begin{tabular}{lll} 'ACTQ & 4.5V to 5.5V \\ Input Voltage (V_I) & 0V to V_{CC} \\ Output Voltage (V_O) & 0V to V_{CC} \\ \end{tabular}$

Operating Temperature (T_A)

54ACTQ

Minimum Input Edge Rate $\Delta V \! / \! \Delta t$

'ACTQ Devices

 V_{IN} from 0.8V to 2.0V V_{CC} @ 4.5V, 5.5V

Note 1: Absolute maximum ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. National does not recommend operation of FACT® circuits outside databook specifications.

Note 2: All commercial packaging is not recommended for applications requiring greater than 2000 temperature cycles from -40°C to $+125^{\circ}\text{C}$.

DC Electrical Characteristics for 'ACTQ Family Devices

±50 mA

±50 mA

-65°C to +150°C

Symbol	Parameter	v _{cc}	54ACTQ Τ _Δ = -55°C to +125°C	Units	Conditions
Зуппол		(V)	Guaranteed Limits		
V _{IH}	Minimum High Level	4.5	2.0	V	V _{OUT} = 0.1V
	Input Voltage	5.5	2.0		or V _{CC} – 0.1V
V _{IL}	Maximum Low Level	4.5	0.8	V	V _{OUT} = 0.1V
	Input Voltage	5.5	0.8		or V _{CC} – 0.1V
V _{OH}	Minimum High Level	4.5	4.4	V	I _{OUT} = -50 μA
	Output Voltage	5.5	5.4		
					(Note 3)
					$V_{IN} = V_{IL} \text{ or } V_{IH}$
		4.5	3.70	V	$I_{OH} = -24 \text{ mA}$
		5.5	4.70		$I_{OH} = -24 \text{ mA}$
V _{OL}	Maximum Low Level	4.5	0.1	V	I _{OUT} = 50 μA
	Output Voltage	5.5	0.1		
					(Note 3)
					$V_{IN} = V_{IL} \text{ or } V_{IH}$
		4.5	0.50	V	I _{OL} = 24 mA
		5.5	0.50		I _{OL} = 24 mA
I _{IN}	Maximum Input	5.5	±1.0	μA	V _I = V _{CC} , GND
	Leakage Current				
l _{oz}	Maximum TRI-STATE	5.5	±10.0	μA	$V_{I} = V_{IL}, V_{IH}$
	Current				$V_O = V_{CC}$, GND
Ісст	Maximum I _{CC} /Input	5.5	1.6	mA	$V_I = V_{CC} - 2.1V$
l _{old}	(Note 4) Minimum Dynamic	5.5	50	mA	V _{OLD} = 1.65V Max
I _{OHD}	Output Current	5.5	-50	mA	V _{OHD} = 3.85V Min
I _{cc}	Maximum Quiescent	5.5	160.0	μA	V _{IN} = V _{CC}
	Supply Current				or GND (Note 5)

DC Electrical Characteristics for 'ACTQ Family Devices (Continued)

Symbol	Parameter	V _{cc} (V)	54ACTQ T _A = -55°C to +125°C Guaranteed Limits	Units	Conditions
V _{OLP}	Quiet Output	5.0	1.5	V	
	Maximum Dynamic V _{OL}				(Notes 6, 7)
V _{OLV}	Quiet Output	5.0	-1.2	V	
	Minimum Dynamic V _{OL}				(Notes 6, 7)

Note 3: All outputs loaded; thresholds on input associated with output under test.

Note 4: Maximum test duration 2.0 ms, one output loaded at a time.

Note 5: I_{CC} for 54ACTQ @ 25 $^{\circ}C$ is identical to 74ACTQ @ 25 $^{\circ}C.$

Note 6: Plastic DIP package.

Note 7: Max number of outputs defined as (n). Data inputs are driven 0V to 3V. One output @ GND.

Note 8: Max number of data inputs (n-1) inputs switching 0V to 3V ('ACTQ). Input-under-test switching: 3V to threshold (V_{ILD}), 0V to threshold. (V_{IHD}), f = 1 MHz.

AC Electrical Characteristics

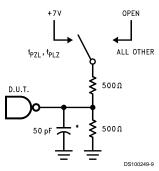
Symbol	Parameter	V _{cc} (V) (Note 9)	54ACTQ T _A = -55°C to +125°C C _L = 50 pF		Units
			Min	Max	
t _{PHL} , t _{PLH}	Propagation Delay	5.0	2.0	9.0	ns
	Data to Output				
t _{PZL} , t _{PZH}	Output Enable Time	5.0	2.0	12.5	ns
t _{PHZ} , t _{PLZ}	Output Disable Time	5.0	1.0	9.0	ns

Note 9: Voltage Range 5.0 is 5.0V ± 0.5 V.

Capacitance

Symbol	Parameter	Тур	Units	Conditions
C _{IN}	Input Capacitance	4.5	pF	V _{CC} = OPEN
C _{PD}	Power Dissipation	82	pF	V _{CC} = 5.0V
	Capacitance			

AC Loading



*Includes jig and probe capacitance

FIGURE 1. Standard AC Test Load

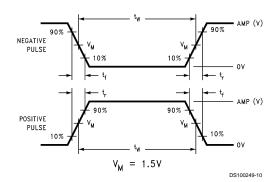


FIGURE 2. Test Input Signal Levels

Amplitude	Rep. Rate	t _w	t _r	t _f
3.0V	1 MHz	500 ns	2.5 ns	2.5 ns

FIGURE 3. Test Input Signal Requirements

AC Waveforms

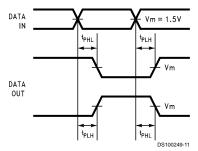


FIGURE 4. Propagation Delay Waveforms for Inverting and Non-Inverting Functions

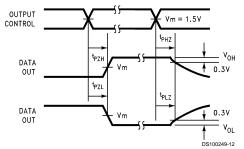
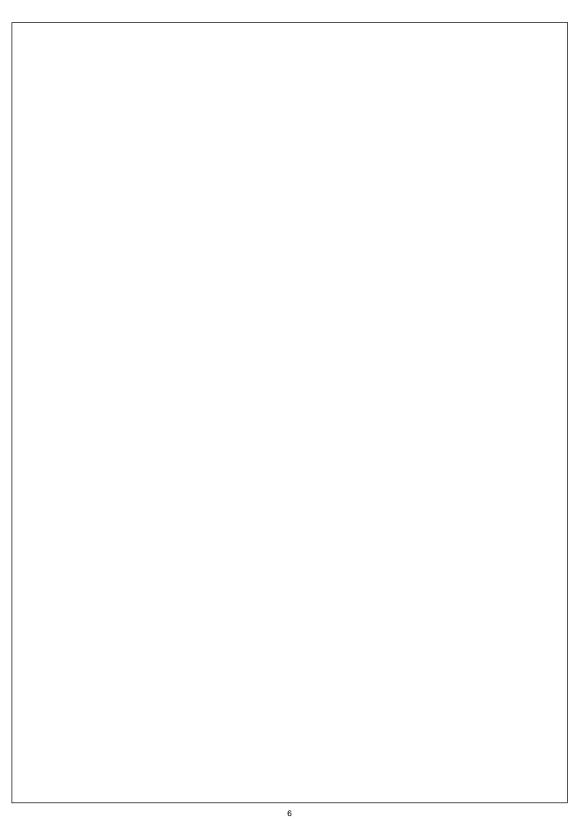
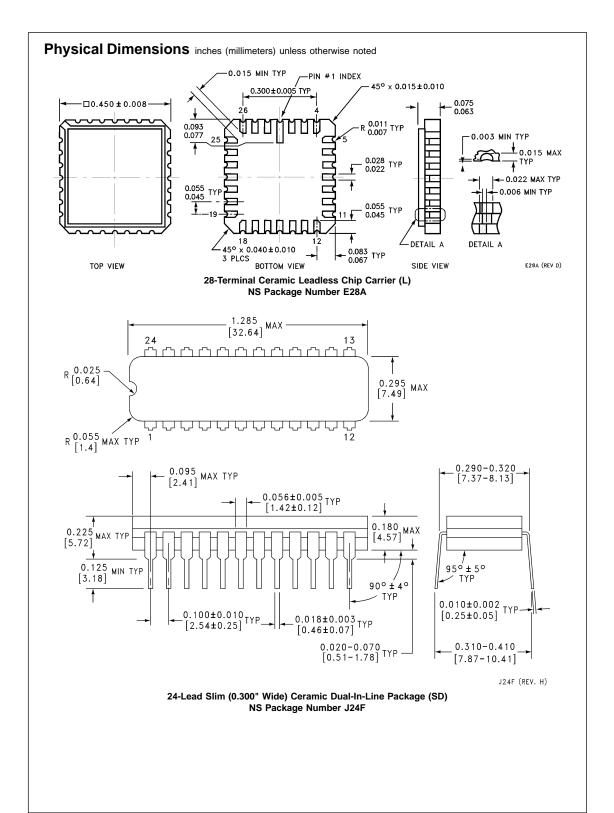
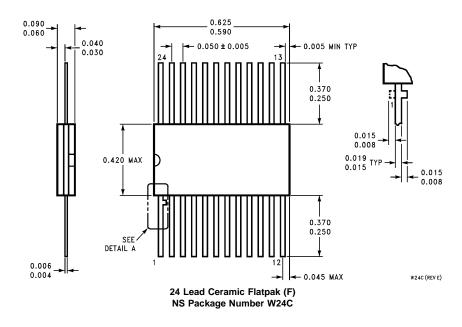


FIGURE 5. TRI-STATE Output HIGH and LOW Enable and Disable Time





Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



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